

Notice of References Cited

Application/Control No.

10/563,723

Applicant(s)/Patent Under
Reexamination
YUAN ET AL.

Examiner

M. Lee

Art Unit

2622

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,489,934	12-2002	Klausner, Judah	345/1.1
*	B	US-2003/0043124	03-2003	Kim et al.	345/204
	C	US-			
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	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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